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November 2013

FDD1600N10ALZD BoostPak (N-Channel PowerTrench[®] MOSFET + Diode) 100 V, 6.8 A, 160 mΩ

Features

- R_{DS(on)} = 124 mΩ (Typ.) @ V_{GS} = 10 V, I_D = 3.4 A
- $R_{DS(on)}$ = 175 m Ω (Typ.) @ V_{GS} = 5.0 V, I_D = 2.1 A
- Low Gate Charge (Typ. 2.78 nC)
- Low C_{rss} (Typ. 2.04 pF)
- · Fast Switching
- 100% Avalanche Tested
- · Improved dv/dt Capability
- RoHS Compliant

Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's PowerTrench[®] process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

The NP diode is hyperfast rectifier with low forward voltage drop and excellent switching performance.

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Applications

- LED Monitor Backlight
- LED TV Backlight
- LED Lighting
- Consumer Appliances, DC-DC converter (Step up & Step down)

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Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		FDD1600N10ALZD	Unit		
V _{DSS}	Drain to Source Voltage	100	V		
V _{GSS}	Gate to Source Voltage		±20	V	
	Drain Current	- Continuous (T _C = 25 ^o C)	6.8		
I _D	Drain Current	- Continuous (T _C = 100°C)	4.3	A	
I _{DM}	Drain Current	- Pulsed (Note 1) 13.6	А	
E _{AS}	Single Pulsed Avalanche Ene) 5.08	mJ		
dv/dt	Peak Diode Recovery dv/dt) 6.0	V/ns		
P _D	Devues Dissisction	(T _C = 25°C)	14.9	W	
	Power Dissipation	- Derate Above 25°C	0.12	W/ºC	
l _F	Diode Continuous Forward Cu	4	А		
I _{FM}	Diode Maximum Forward Cur	40	А		
T _J , T _{STG}	Operating and Storage Tempe	-55 to +150	°C		
TL	Maximum Lead Temperature	for Soldering, 1/8" from Case for 5 Seconds	300	°C	

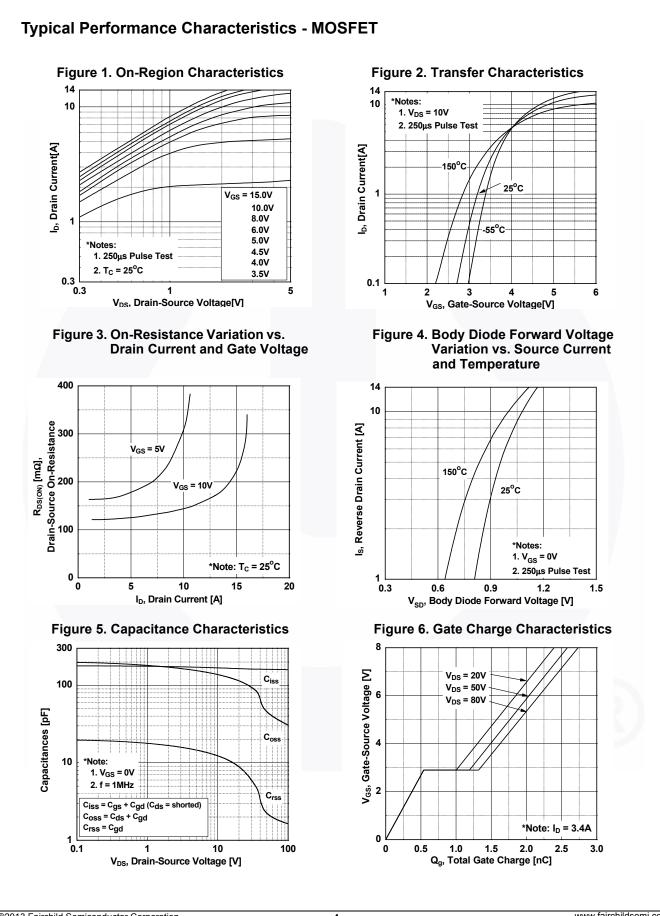
Thermal Characteristics

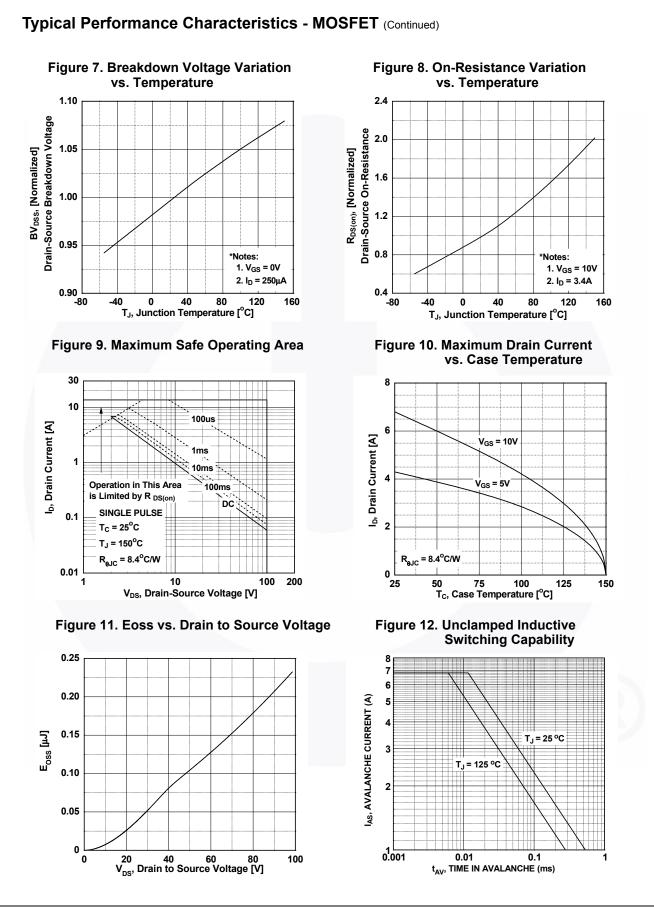
Symbol	Parameter	FDD1600N10ALZD	Unit	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case for MOSFET, Max.	8.4		
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case for Diode, Max.	3.3	°C/W	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient, Max.	87		

		Package	• •			Tape Width 16 mm		Quantity 2500 units		
		TO-252 5								
Electrica	l Chara	cteristics of t	he MOSI	FET T _C = 25°	C unless	otherwise not	ed.			
Symbol		Parameter		Test	Conditio	ons	Min.	Тур.	Max.	Unit
Off Chara	cteristics									
BV _{DSS}	Drain to \$	Source Breakdown Vo	Itage	I _D = 250 μA, V	_{GS} = 0 V		100	-	-	V
∆BV _{DSS}		wn Voltage Temperatu		$I_D = 250 \mu$ A, Referenced to 25° C			_	0.1		V/ºC
$/\Delta T_J$	Coefficie	nt				u to 25 C	-	0.1	-	v/-C
I _{DSS}	Zero Gat	Zero Gate Voltage Drain Current		V _{DS} = 80 V, V _{GS} = 0 V			-	-	1	μA
		-		V _{DS} = 80 V, V ₀			-	-	500	
I _{GSS}	Gate to S	Source Leakage Curre	nt	V _{GS} = ±20 V, V	/ _{DS} = 0 V	/	-	-	±10	μA
On Charao	cteristics									
V _{GS(th)}	Gate Thr	eshold Voltage		V _{GS} = V _{DS} , I _D = 250 μA			1.4	2.1	2.8	V
	Ctatia Da			$V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$			-	124	160	
R _{DS(on)}	Static Dra	ain to Source On Resi	stance	V _{GS} = 5 V, I _D =	= 2.1 A		-	175	375	mΩ
9 _{FS}	Forward	Transconductance		$V_{\rm DS} = 10 \text{ V}, \text{ I}_{\rm D} = 6.8 \text{ A}$			-	19.6	-	S
Dynamic (Character	ristics								
C _{iss}	-	pacitance			-		-	169	225	pF
C _{oss}		apacitance		$V_{\rm DS} = 50 \text{ V}, \text{ V}_{\rm GS} = 0 \text{ V},$		_	43	55	pF	
C _{rss}		Transfer Capacitance		f = 1 MHz		-	-	2.04	-	pF
C _{oss(er)}		Related Output Capacit	ance	V _{DS} = 50 V, V ₀	v 0 = 2		_	85	-	pF
Q _{g(tot)}		e Charge at 10V		V _{GS} = 10 V	33		-	2.78	3.61	nC
Q _{g(tot)}		e Charge at 5V		V _{GS} = 5 V				1.5	1.95	nC
Q _{gs}		Source Gate Charge		00			-	0.72	-	nC
Q _{gd}		Drain "Miller" Charge				-	0.56	-	nC	
V _{plateau}	Gate Plat	teau Volatge		-		(Note 4)	-	4.02	-	V
Q _{sync}	Total Gat	e Charge Sync.		V _{DS} = 0 V, I _D = 3.4 A		-	2.5	-	nC	
Q _{oss}	Output Charge			V _{DS} = 50 V, V _{GS} = 0 V			-	5.2	-	nC
Switching	Characte	eristics				<u>`</u>				
		Delay Time						7	24	nc
t _{d(on)} t		Rise Time		$V_{DD} = 50 \text{ V}, \text{ I}_{D} = 6.8 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{G} = 4.7 \Omega$		-	2	14	ns ns	
t _r		Delay Time				-	13	36	ns	
t _{d(off)} t _f	Turn-Off	,				(Note 4)		2	14	ns
4 ESR		nt Series Resistance (G-S)	f = 1 MHz		(Note 4)		2.1	-	Ω
				1 - 1 101112				2.1		32
	1	e Characteristics		E					0.0	
l _S		Continuous Drain to			ent		-	-	6.8	A
I _{SM}	Maximum Pulsed Drain to Source Diode F Drain to Source Diode Forward Voltage			$V_{GS} = 0 \text{ V}, \text{ I}_{SD} = 6.8 \text{ A}$			-		13.6 1.3	A V
V _{SD}			vollage			V 50.V	-	-	1.3	
t _{rr}		Recovery Time Recovery Charge		V _{GS} = 0 V, I _{SD} dI _F /dt = 100 A/		$v_{\rm DS} = 50 \ V,$	-	37 42	-	ns nC
Q _{rr}	Reveise	Recovery Charge			μο		-	42	-	

Symbol	Parameter Test		ditions	Min.	Тур. -	Max.	Unit V
V _R	DC Blocking Voltage	I _R = 1 mA	150				
V _{FM}	Maximum Instantaneous Fanuard Valtage	1 - 4 4	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	-	2.5	v
	Maximum Instantaneous Forward Voltage	I _F = 4 A	T _C = 125°C	-	1.01	-	
I _{RM}	Maximum instantaneous Reverse (Jurrent (a) rated VR		$T_{C} = 25^{\circ}C$	-	-	50	uA
			T _C = 125°C	-	-	1000	
+	Diada Davara Daaavar Tiraa		$T_{\rm C} = 25^{\rm o}{\rm C}$	-	12.7	26	20
۲r	Diode Reverse Recovery Time		T _C = 125°C	-	17.1	-	ns
1	Diode Peak Reverse Recovery Current	I _F = 4 A, dI/dt = 200 A/μs	$T_C = 25^{\circ}C$	-	2.6	6	A
'rr	Didde Fear Reverse Recovery Current	αι/αι – 200 Α/μ5	T _C = 125°C	-	3.8	-	
0	Diada Bayaraa Baaayary Charga		$T_C = 25^{\circ}C$	-	18.3	-	nC
Q _{rr}	Diode Reverse Recovery Charge		T _C = 125°C	-	35.7	-	
W _{AVL}	Avalanche Energy (L = 40 mH)	Avalanche Energy (L = 40 mH)			-	-	mJ

Electrical Characteristics of the Diode T_C = 25°C unless otherwise noted.

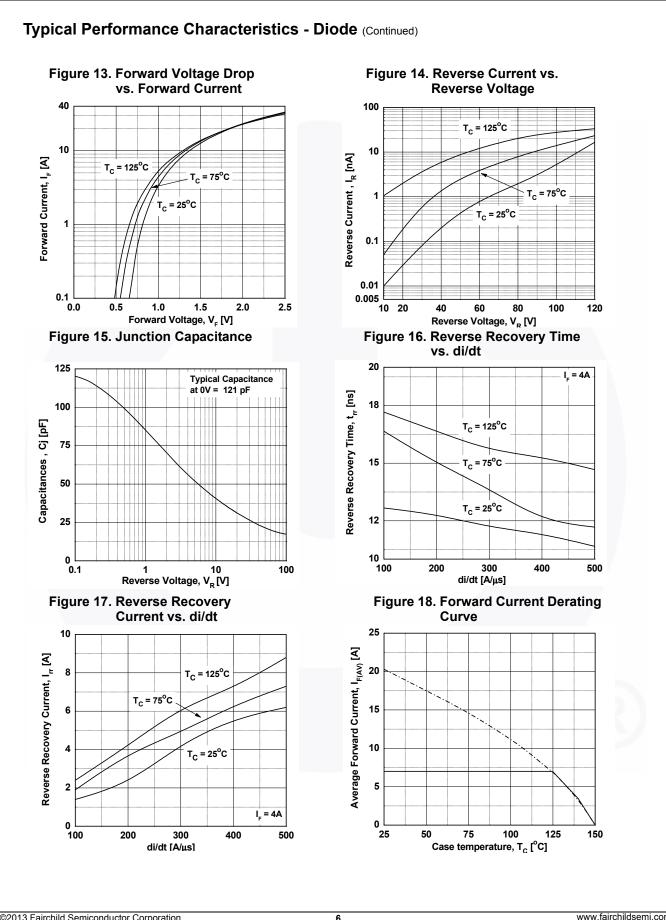




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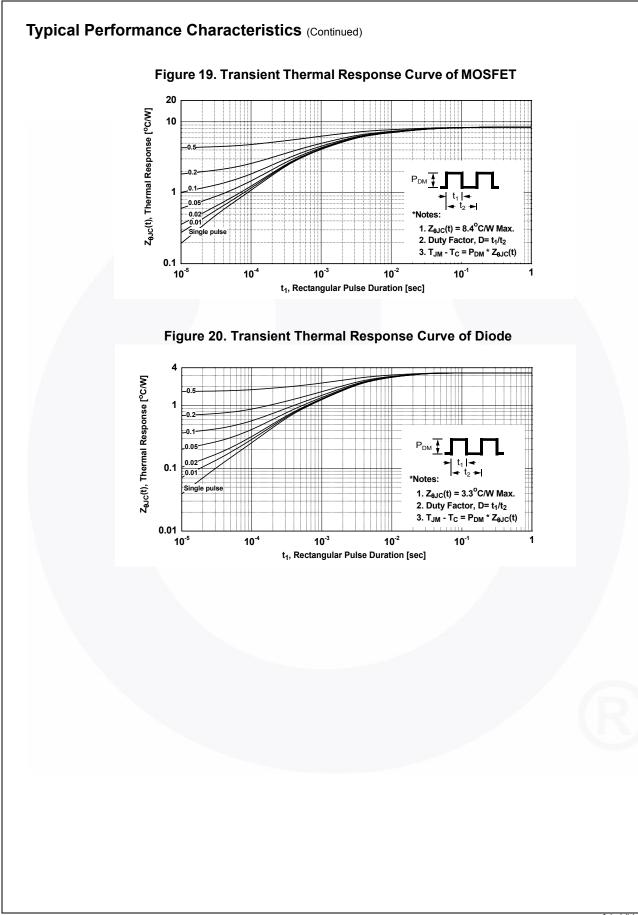
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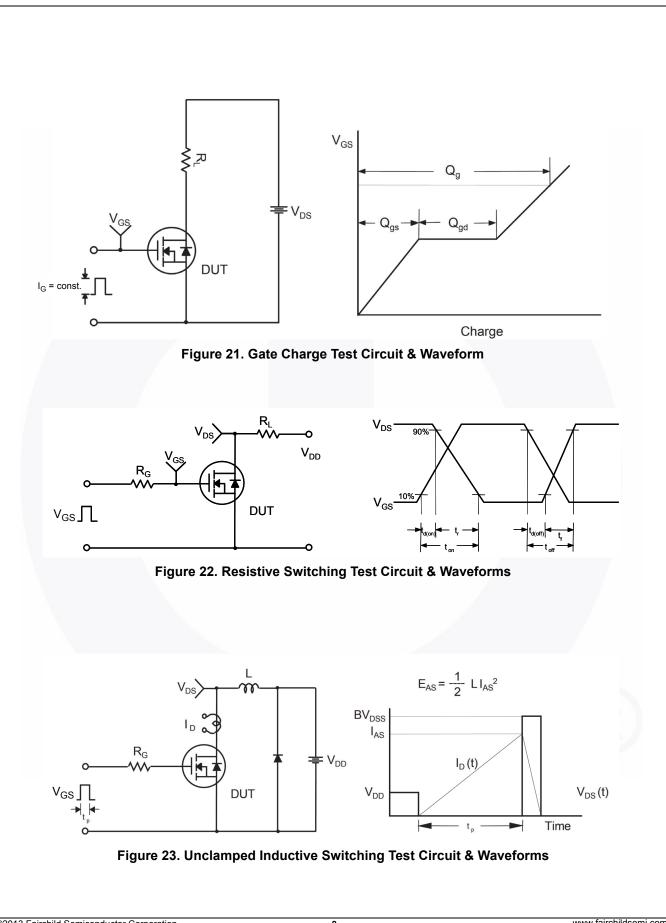
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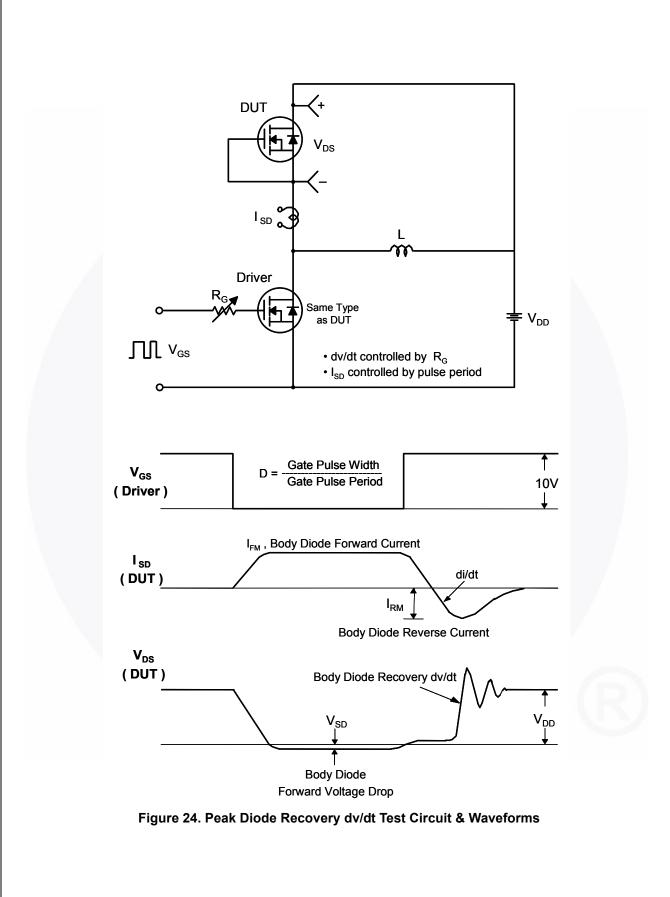
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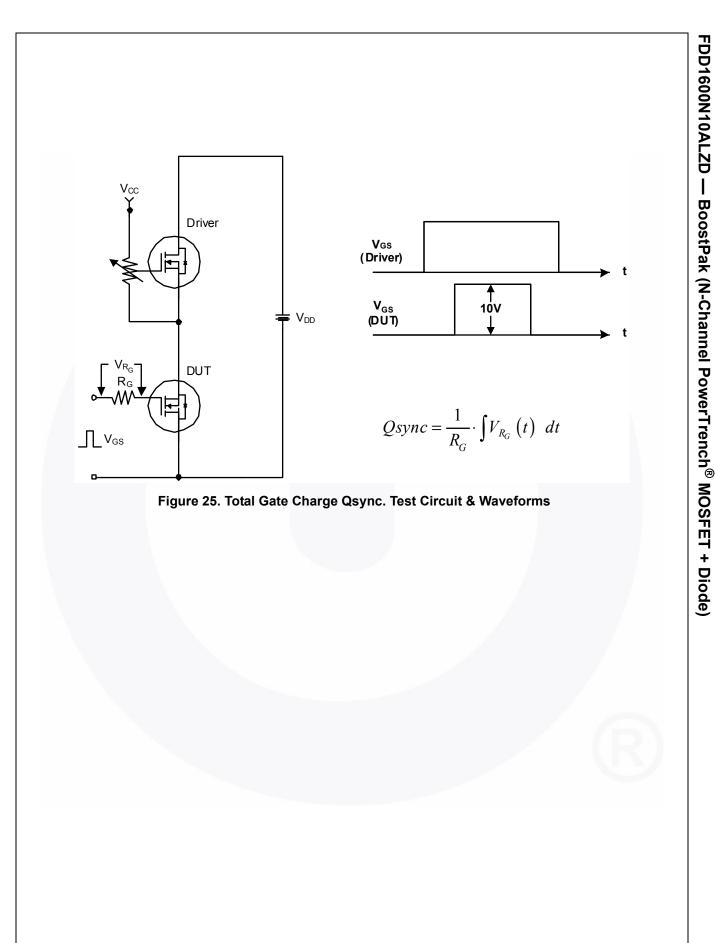
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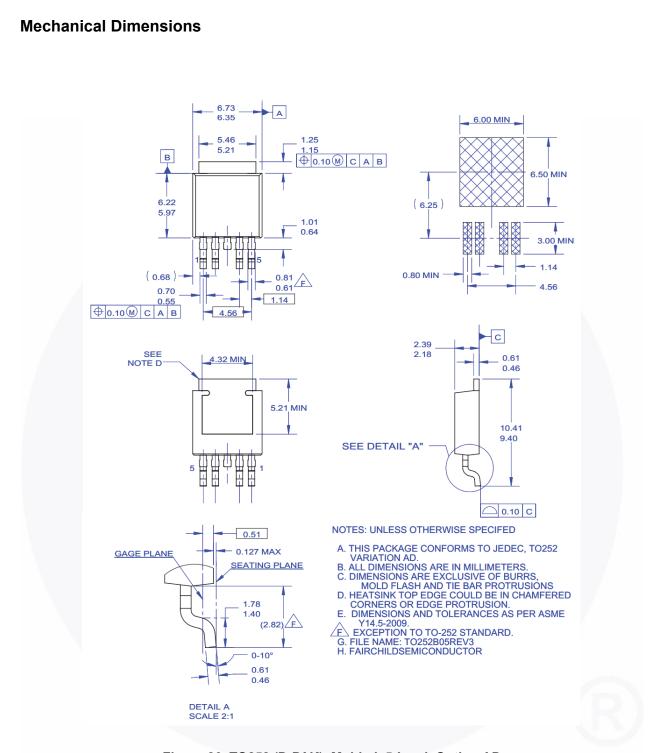


Figure 26. TO252 (D-PAK), Molded, 5-Lead, Option AD

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